


<b>Search Notes</b> 	<b>Application/Control No.</b> 10715986	<b>Applicant(s)/Patent Under Reexamination</b> ZHANG ET AL.
	<b>Examiner</b> Toth, Karen E	<b>Art Unit</b> 3735

SEARCHED			
Class	Subclass	Date	Examiner
600	534, 538	1/17/07	ket

SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST (USPAT, USPGPUB)	1/17/07	ket
Class/subclass search	1/17/07	ket
PALM inventor name search	1/17/07	ket
see attached		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner